

Search Notes

Application/Control No.

10/747,644

Examiner

Eva Yi Zheng

Applicant(s)/Patent under
Reexamination

DEMIR ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	322	11/14/2006	E.Z
375	316	11/14/2006	E.Z
455	249	11/14/2006	E.Z

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST(USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM- TDB)	11/14/2006	E.Z

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner